

**Search Notes**

Application/Control No.

10/620,285

Examiner

Binh C. Tat

Applicant(s)/Patent under  
Reexamination

PACK ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	19-21	4/16/2005	BT
430	5,22,30	4/16/2005	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	4/16/2005	BT
IEEE	4/16/2005	BT